INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Not for submission under 37 CFR 1.99)	Application Number	10620284	
	Filing Date	2003-07-14	
	First Named Inventor	Robert PACK	
	Art Unit	2825	
	Examiner Name	Tat, Binh C.	
	Attorney Docket Number	CA7010502001	

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B̸D̸	2	McCALL, J. et al. "Integrated method of mask data checking and inspection data prep for manufacturable mask inspection: inspection rule violations" Proceedings of the SPIE - The International Society for Optical Engineering (Oct. 3, 2001) 4562:161-170	☐
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